CLAIMS

What is claimed is:

- An electrode structure for a display device having at least one emitter, comprising:

 a first electrode located adjacent said at least one emitter;
 a second electrode; and

 an insulating layer disposed between the first electrode and the second electrode including a ridge located closer to said at least one emitter than a portion of first electrode or a portion of the second electrode.
- 2. The electrode structure of claim 1, wherein the second electrode comprises a layer of conductive material disposed on a plane over the insulating layer, and the first electrode comprises a layer of conductive material disposed on a plane under the insulating layer.
- 3. The electrode structure of claim 2, wherein the first electrode is a gate electrode and the second electrode is a focusing electrode.
- 4. The electrode structure of claim 3, wherein the insulating layer comprises silicon oxide.
- 5. The electrode structure of claim 1, wherein a second insulating layer is disposed between the insulating layer and the first electrode.
- 6. The electrode structure of claim 5, wherein the second insulating layer comprises silicon nitride.
- 7. The electrode structure of claim 1, wherein the first electrode comprises a first layer of conductive material and the second electrode comprises a second layer of conductive material, the first and second layers of conductive material being disposed on a single plane above the emitter.

- 8. The electrode structure of claim 7, wherein the insulating layer further comprises a ridge protruding above an upper surface of the first electrode or the second electrode.
- 9. The electrode structure of claim 8, wherein the insulating layer comprises silicon oxide.
- 10. The electrode structure of claim 1, wherein at least one of the first electrode and the second electrode comprises polysilicon, titanium, aluminum, or tungsten.
- 11. The electrode structure of claim 2, further comprising: at least one additional insulation layer disposed on a plane over the second electrode; and at least one additional electrode comprising a layer of conductive material disposed on a plane over the at least one additional insulation layer.
- 12. The electrode structure of claim 7, further comprising:
 at least one additional electrode comprising a layer of conductive material disposed on the single
 plane above the emitter; and
- at least one additional insulating layer disposed between the second electrode and the at least one additional electrode.
- 13. A display device, comprising an electrode structure having: a gate electrode located adjacent an emitter;
- a focusing electrode; and
- an insulating layer disposed between the gate electrode and the focusing electrode including a ridge protruding closer to the emitter than one of a sidewall of the gate electrode and a sidewall of the focusing electrode.

- 14. The device of claim 13, wherein the focusing electrode comprises a layer of conductive material disposed on a plane over the insulating layer, and the gate electrode comprises a layer of conductive material disposed on a plane under the insulating layer.
 - 15. The device of claim 14, wherein the insulating layer comprises silicon oxide.
- 16. The device of claim 15, wherein a second insulating layer is disposed between the insulating layer and the gate electrode.
- 17. The device of claim 16, wherein the second insulating layer comprises silicon nitride.
- 18. The device of claim 13, wherein the gate electrode comprises a first layer of conductive material and the focusing electrode comprises second a layer of conductive material, the first and second layers of conductive material being disposed on a single plane above the emitter.
- 19. The device of claim 18, wherein the insulating layer further comprises a ridge protruding above an upper surface of the gate electrode or the focusing electrode.
 - 20. The device of claim 19, wherein the insulating layer comprises silicon oxide.
- 21. The device of claim 13, wherein at least one of the gate electrode and the focusing electrode comprises polysilicon, titanium, aluminum, or tungsten.
- 22. The device of claim 14, further comprising: at least one additional insulation layer disposed on a plane over the focusing electrode; and at least one additional electrode comprising a layer of conductive material disposed on a plane over the at least one additional insulation layer.

- 23. The device of claim 18, further comprising:
- at least one additional electrode comprising a layer of conductive material disposed on the single plane above the emitter; and
- at least one additional insulating layer disposed between the focusing electrode and the at least one additional electrode.